



## TSP640M / TSF640M 200V N-Channel MOSFET

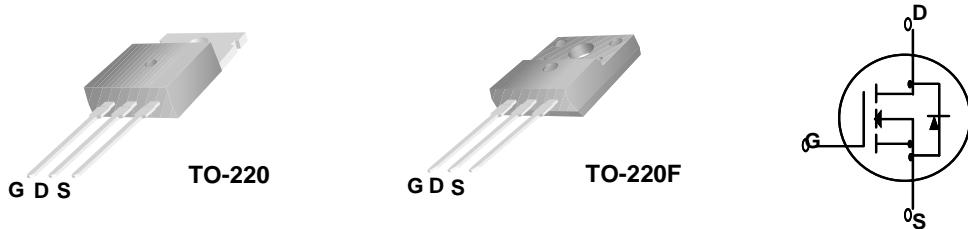
### General Description

This Power MOSFET is produced using Truesemi's advanced planar stripe DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies, active power factor correction based on half bridge topology.

### Features

- 18.0A, 200V,  $R_{DS(on)} = 0.18\Omega$  @  $V_{GS} = 10$  V
- Low gate charge ( typical 40nC)
- High ruggedness
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



### Absolute Maximum Ratings

$T_C = 25^\circ\text{C}$  unless otherwise noted

| Symbol         | Parameter  | TSP640M  | TSF640M     | Units               |   |
|----------------|--|----------|-------------|---------------------|---|
| $V_{DSS}$      | Drain-Source Voltage   | 200      |             | V                   |   |
| $I_D$          | Drain Current - Continuous ( $T_C = 25^\circ\text{C}$ )                          | 18.0     | 18.0*       | A                   |   |
|                | - Continuous ( $T_C = 100^\circ\text{C}$ )                                       | 12.0     | 12.0 *      | A                   |   |
| $I_{DM}$       | Drain Current - Pulsed   | (Note 1) | 72          | 72 *                | A |
| $V_{GSS}$      | Gate-Source Voltage  |          | $\pm 30$    | V                   |   |
| $E_{AS}$       | Single Pulsed Avalanche Energy   | (Note 2) | 432         | mJ                  |   |
| $E_{AR}$       | Repetitive Avalanche Energy  | (Note 1) | 13.9        | mJ                  |   |
| $dv/dt$        | Peak Diode Recovery $dv/dt$  | (Note 3) | 5.5         | V/ns                |   |
| $P_D$          | Power Dissipation ( $T_C = 25^\circ\text{C}$ )                                   | 139      | 43          | W                   |   |
|                | - Derate above $25^\circ\text{C}$  | 1.11     | 0.34        | W/ $^\circ\text{C}$ |   |
| $T_J, T_{STG}$ | Operating and Storage Temperature Range  |          | -55 to +150 | $^\circ\text{C}$    |   |
| $T_L$          | Maximum lead temperature for soldering purposes,<br>1/8" from case for 5 seconds |          | 300         | $^\circ\text{C}$    |   |

\* Drain current limited by maximum junction temperature.

### Thermal Characteristics

| Symbol          | Parameter                               | TSP640M | TSF640M | Units                     |
|-----------------|---|---------|---------|---------------------------|
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case    | 0.9     | 2.89    | $^\circ\text{C}/\text{W}$ |
| $R_{\theta CS}$ | Thermal Resistance, Case-to-Sink Typ.   | 0.5     | --      | $^\circ\text{C}/\text{W}$ |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | 62.5    | 62.5    | $^\circ\text{C}/\text{W}$ |



# TSP640M / TSF640M

## Electrical Characteristics

$T_C = 25^\circ\text{C}$  unless otherwise noted

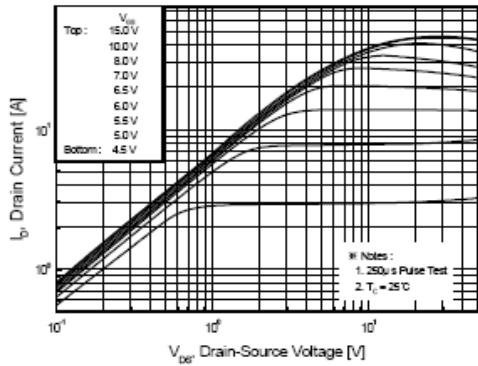
| Symbol  | Parameter   | Test Conditions  | Min      | Typ  | Max  | Units                     |
|---|---|--|----------|------|------|---------------------------|
| <b>Off Characteristics</b>                                    |   |  |          |      |      |                           |
| $\text{BV}_{\text{DSS}}$                                      | Drain-Source Breakdown Voltage                        | $V_{\text{GS}} = 0 \text{ V}, I_D = 250 \mu\text{A}$                                       | 200      | --   | --   | V                         |
| $\Delta \text{BV}_{\text{DSS}} / \Delta T_J$                  | Breakdown Voltage Temperature Coefficient             | $I_D = 250 \mu\text{A}$ , Referenced to $25^\circ\text{C}$                                 | --       | 0.25 | --   | $\text{V}/^\circ\text{C}$ |
| $I_{\text{DSS}}$  | Zero Gate Voltage Drain Current                       | $V_{\text{DS}} = 200 \text{ V}, V_{\text{GS}} = 0 \text{ V}$                               | --       | --   | 1    | $\mu\text{A}$             |
|   |   | $V_{\text{DS}} = 160 \text{ V}, T_C = 125^\circ\text{C}$                                   | --       | --   | 10   | $\mu\text{A}$             |
| $I_{\text{GSSF}}$   | Gate-Body Leakage Current, Forward                    | $V_{\text{GS}} = 30 \text{ V}, V_{\text{DS}} = 0 \text{ V}$                                | --       | --   | 100  | nA                        |
| $I_{\text{GSSR}}$   | Gate-Body Leakage Current, Reverse                    | $V_{\text{GS}} = -30 \text{ V}, V_{\text{DS}} = 0 \text{ V}$                               | --       | --   | -100 | nA                        |
| <b>On Characteristics</b>                                     |   |  |          |      |      |                           |
| $V_{\text{GS(th)}}$   | Gate Threshold Voltage                                | $V_{\text{DS}} = V_{\text{GS}}, I_D = 250 \mu\text{A}$                                     | 2.0      | --   | 4.0  | V                         |
| $R_{\text{DS(on)}}$   | Static Drain-Source On-Resistance                     | $V_{\text{GS}} = 10 \text{ V}, I_D = 9.0 \text{ A}$  | --       | 0.14 | 0.18 | $\Omega$                  |
| <b>Dynamic Characteristics</b>                                |   |  |          |      |      |                           |
| $C_{\text{iss}}$  | Input Capacitance                                     | $V_{\text{DS}} = 25 \text{ V}, V_{\text{GS}} = 0 \text{ V}, f = 1.0 \text{ MHz}$           | --       | 850  | --   | pF                        |
| $C_{\text{oss}}$  | Output Capacitance                                    |  | --       | 190  | --   | pF                        |
| $C_{\text{rss}}$  | Reverse Transfer Capacitance                          |  | --       | 80   | --   | pF                        |
| <b>Switching Characteristics</b>                              |   |  |          |      |      |                           |
| $t_{\text{d(on)}}$  | Turn-On Delay Time                                    | $V_{\text{DD}} = 100 \text{ V}, I_D = 18.0 \text{ A}, R_G = 25 \Omega$                     | --       | 20   | --   | ns                        |
| $t_r$   | Turn-On Rise Time                                     |  | --       | 150  | --   | ns                        |
| $t_{\text{d(off)}}$   | Turn-Off Delay Time                                   |  | --       | 140  | --   | ns                        |
| $t_f$   | Turn-Off Fall Time                                    |  | --       | 120  | --   | ns                        |
| $Q_g$   | Total Gate Charge                                     | $V_{\text{DS}} = 160 \text{ V}, I_D = 18.0 \text{ A}, V_{\text{GS}} = 10 \text{ V}$        | --       | 40   | --   | nC                        |
| $Q_{\text{gs}}$   | Gate-Source Charge                                    |  | --       | 6.0  | --   | nC                        |
| $Q_{\text{gd}}$   | Gate-Drain Charge                                     |  | --       | 22.0 | --   | nC                        |
| <b>Drain-Source Diode Characteristics and Maximum Ratings</b> |   |  |          |      |      |                           |
| $I_S$   | Maximum Continuous Drain-Source Diode Forward Current | --   | --       | 18.0 | --   | A                         |
| $I_{\text{SM}}$   | Maximum Pulsed Drain-Source Diode Forward Current     | --   | --       | 72.0 | --   | A                         |
| $V_{\text{SD}}$   | Drain-Source Diode Forward Voltage                    | $V_{\text{GS}} = 0 \text{ V}, I_S = 18.0 \text{ A}$  | --       | --   | 1.5  | V                         |
| $t_{\text{rr}}$   | Reverse Recovery Time                                 | $V_{\text{GS}} = 0 \text{ V}, I_S = 18.0 \text{ A}, dI_F / dt = 100 \text{ A}/\mu\text{s}$ | --       | 200  | --   | ns                        |
| $Q_{\text{rr}}$   | Reverse Recovery Charge                               |  | (Note 4) | --   | 1.6  | $\mu\text{C}$             |

**Notes:**

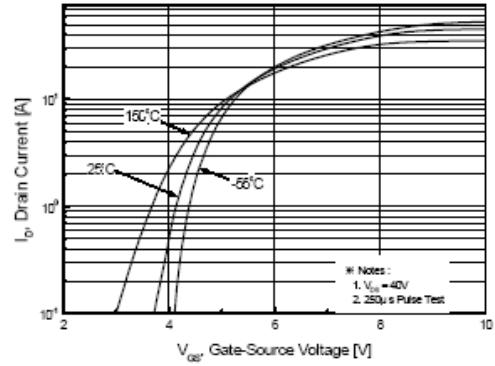
1. Repetitive Rating : Pulse width limited by maximum junction temperature
2.  $L = 2\text{mH}$ ,  $I_{AS} = 18.0 \text{ A}$ ,  $V_{DD} = 50\text{V}$ ,  $R_G = 25 \Omega$ , Starting  $T_J = 25^\circ\text{C}$
3.  $I_{Sp} \leq 18.0 \text{ A}$ ,  $dI/dt \leq 200\text{A}/\mu\text{s}$ ,  $V_{DD} \leq \text{BV}_{\text{DSS}}$ , Starting  $T_J = 25^\circ\text{C}$
4. Pulse Test : Pulse width  $\leq 300\mu\text{s}$ , Duty cycle  $\leq 2\%$
5. Essentially independent of operating temperature



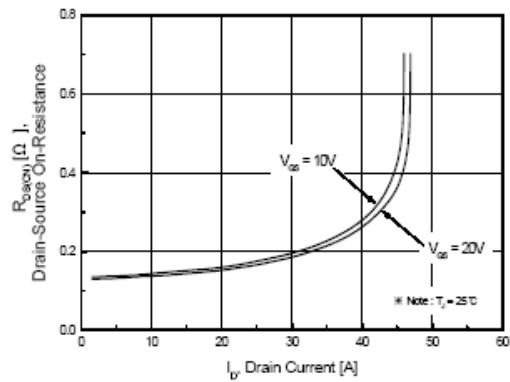
## Typical Characteristics



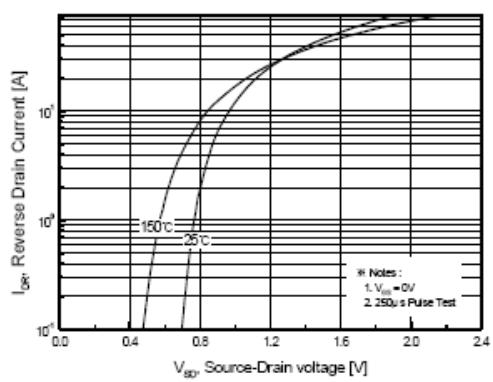
**Figure 1. On-Region Characteristics**



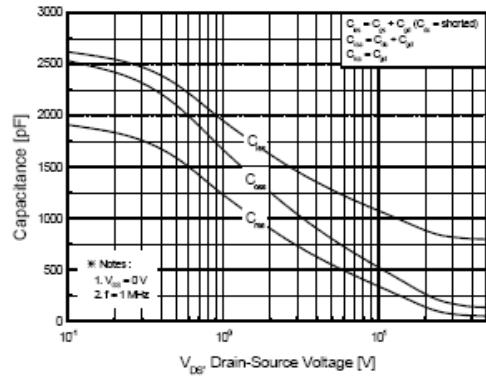
**Figure 2. Transfer Characteristics**



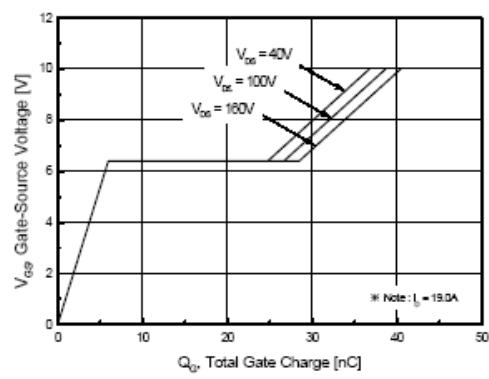
**Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage**



**Figure 4. Body Diode Forward Voltage Variation with Source Current**



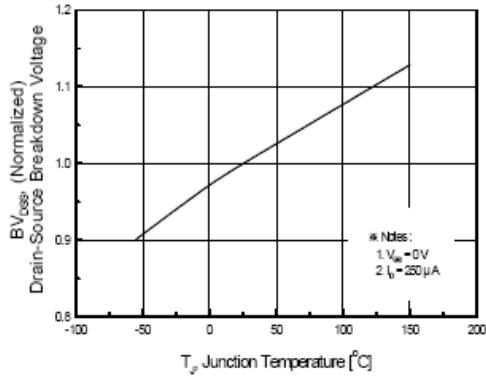
**Figure 5. Capacitance Characteristics**



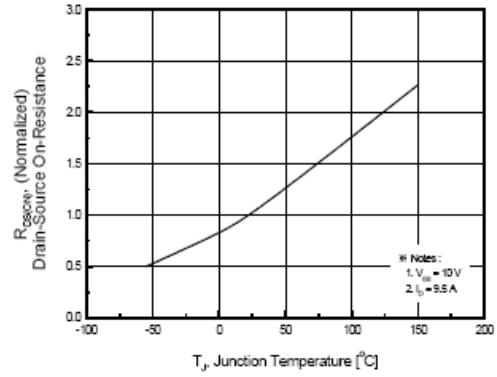
**Figure 6. Gate Charge Characteristics**



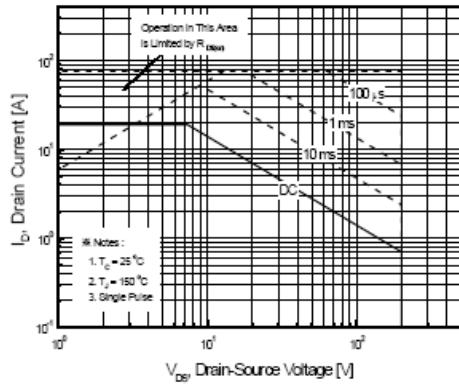
## Typical Characteristics (Continued)



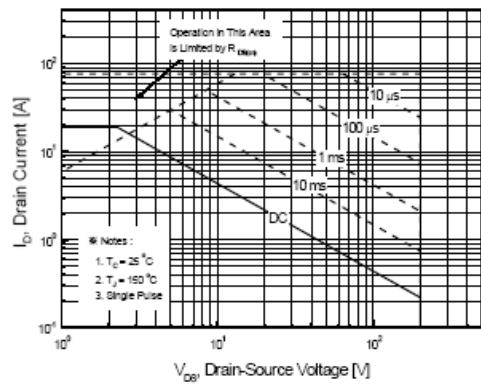
**Figure 7. Breakdown Voltage Variation vs Temperature**



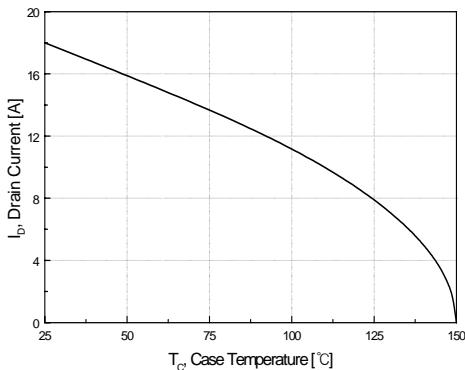
**Figure 8. On-Resistance Variation vs Temperature**



**Figure 9-1. Maximum Safe Operating Area for TSP640M**



**Figure 9-2. Maximum Safe Operating Area for TSF640M**



**Figure 10. Maximum Drain Current vs Case Temperature**

## Typical Characteristics (Continued)

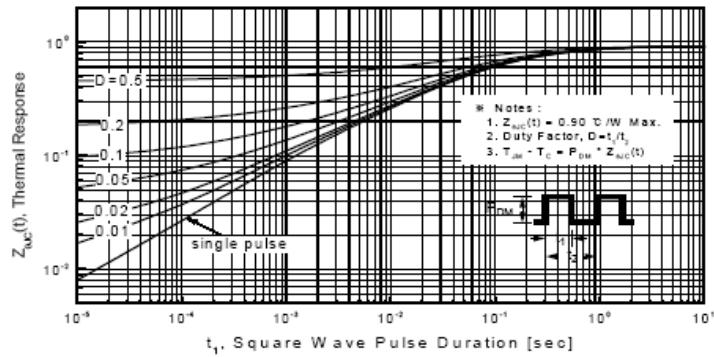


Figure 11-1. Transient Thermal Response Curve  
for TSP640M

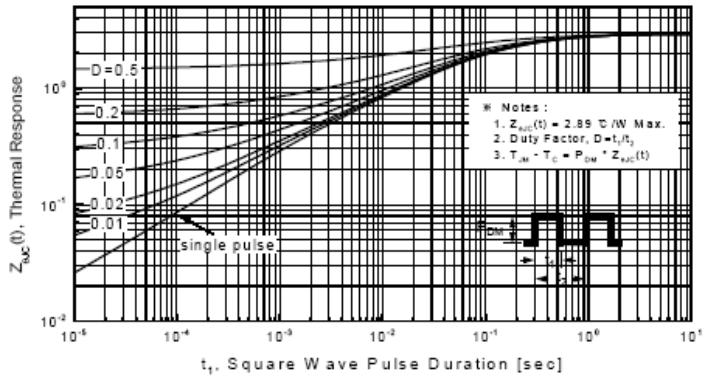
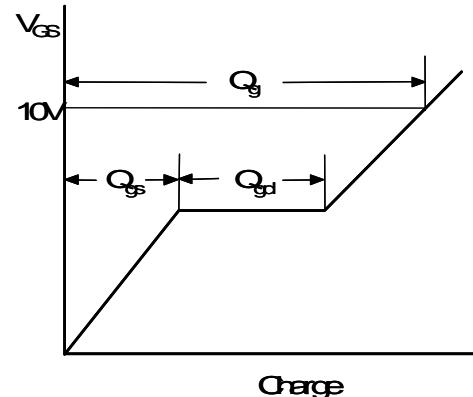
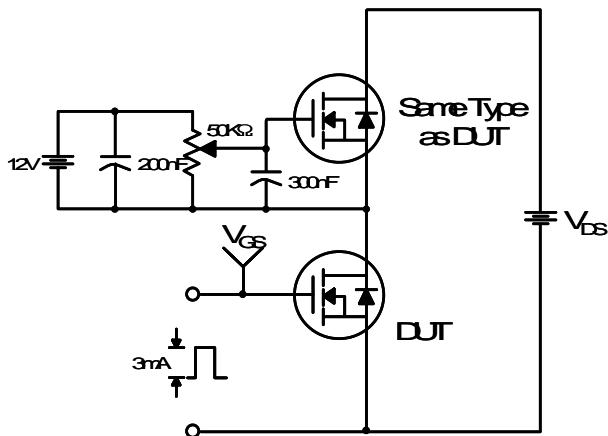
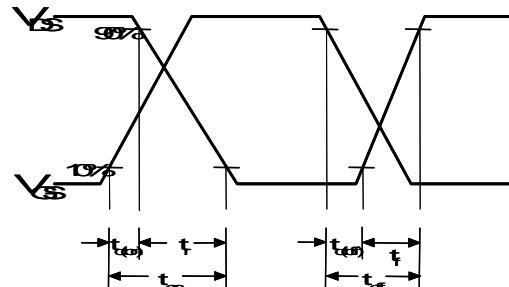
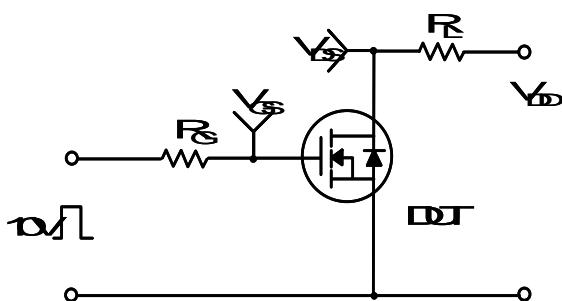


Figure 11-2. Transient Thermal Response Curve  
for TSF640M

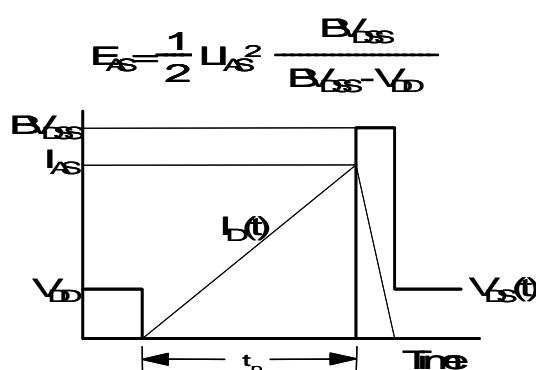
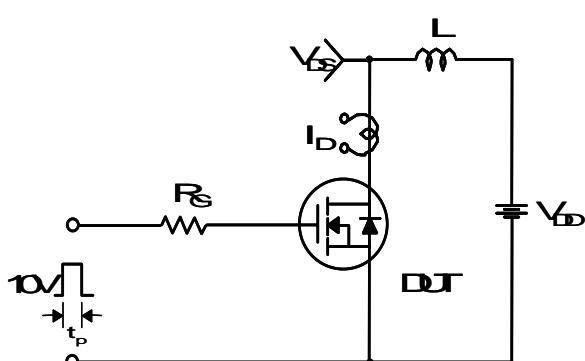
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms



### Peak Diode Recovery dv/dt Test Circuit & Waveforms

